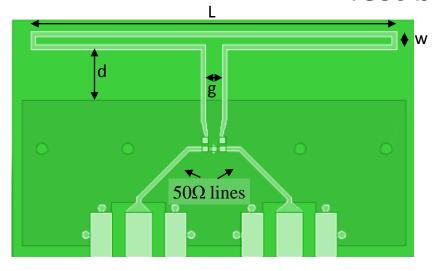
Test board 5



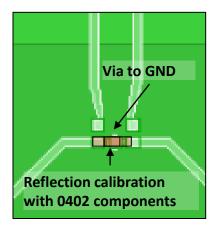
•	The layer stacking is identical to board 1 (62
	mil), but:

- no ground layer patch underneath the feedlines
- the length, L, shortened to move the resonant frequency higher
- the gap, g, between the feedlines was increased from 59 mils to 79 mils
- Full-port calibration performed across ports with a shared via to ground in the center.

Layer	Thickness (mils)	Characteristics
Top solder mask	1.00	$\varepsilon_{\rm r} = 3.8$, tan $\delta = 0$
Тор	1.24	$\sigma = 5.81*10^7 \text{ S/m}$
FR4	10.20	$\epsilon_{\rm r}=3.7940,\tan\delta=0.0183$
Ground	1.18	$\sigma = 5.81*10^7 \text{ S/m}$
FR4	36.52	$\epsilon_{\rm r}=3.9920,\tan\delta=0.0165$
Vcc	1.18	$\sigma = 5.81*10^7 \text{ S/m}$
FR4	10.20	$\epsilon_{\rm r}=3.7940,\tan\delta=0.0183$
Bottom	1.24	$\sigma = 5.81*10^7 \text{ S/m}$
Bottom solder mask	1.00	$\varepsilon_{\rm r}=3.8, {\rm tan} \delta=0$
TOTAL	63.8	

L = 1697 mils w = 83 mils g = 79 mils d = 237.5 mils

trace width = 20 mils



^{*} Do transmission (through) calibration with 0805 0Ω across ports

Test boards 3 & 4: Balun and Two-port Measurements and Simulations

